

Search Notes

Application/Control No.

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Examiner

THANH S. PHAN

Applicant(s)/Patent under
Reexamination

EIDSON ET AL.

Art Unit

2833

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted Tuan Dinh, primary Ex 2841	5/11/2008	TSP
consulted I Patel, primary Ex 2841	5/7/2008	tsp